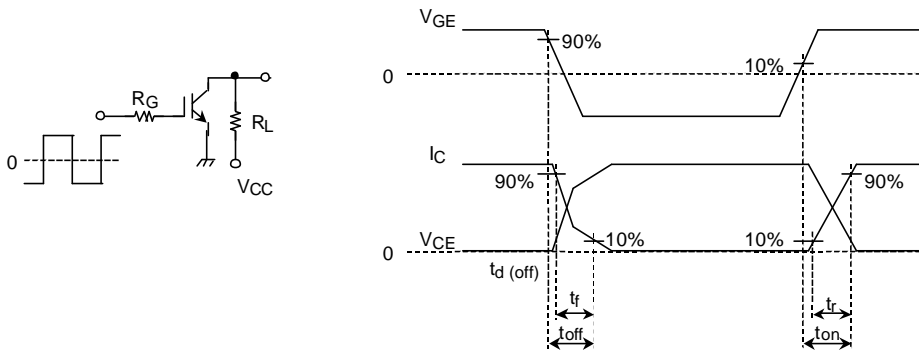




**Electrical Characteristics (Ta = 25°C)**

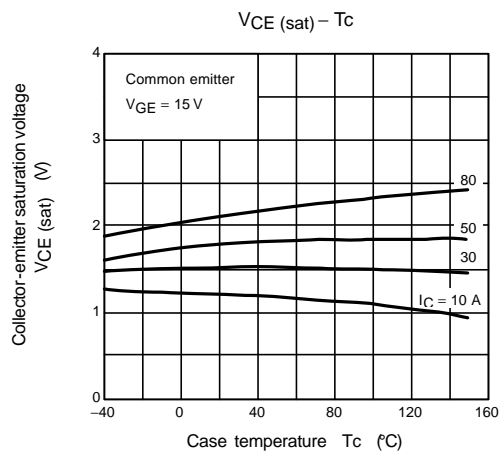
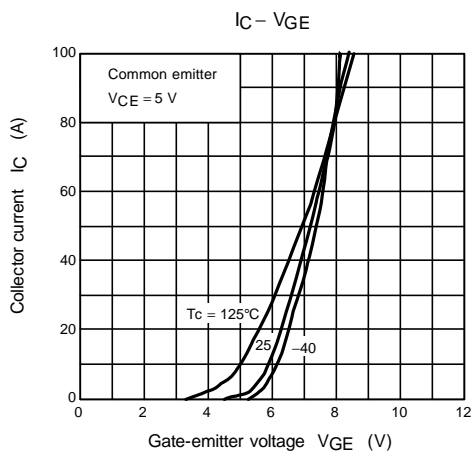
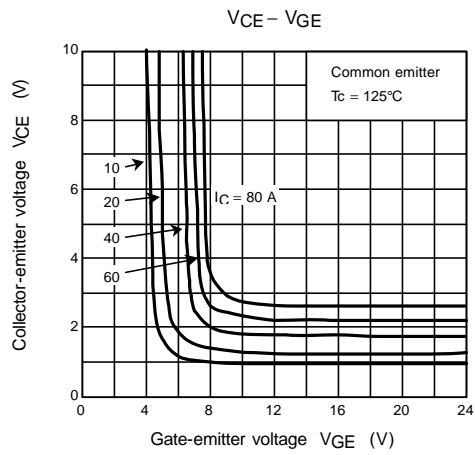
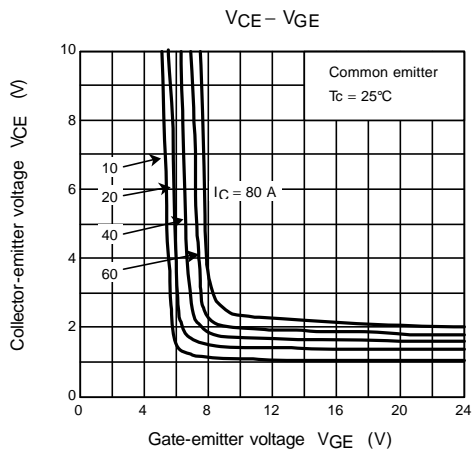
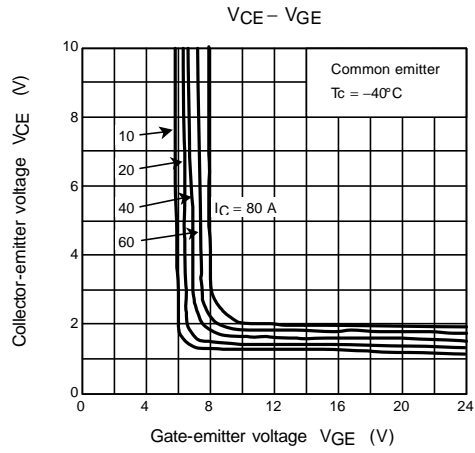
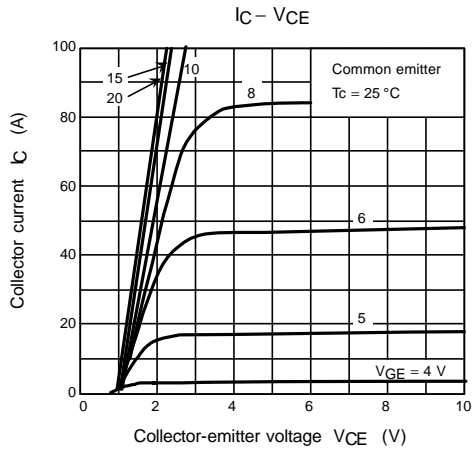
Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		$I_{GES}$	$V_{GE} = \pm 25\text{ V}, V_{CE} = 0$	—	—	$\pm 500$	nA
Collector cut-off current		$I_{CES}$	$V_{CE} = 600\text{ V}, V_{GE} = 0$	—	—	1.0	mA
Gate-emitter cut-off voltage		$V_{GE (OFF)}$	$V_{CE} = 5\text{ V}, I_C = 80\text{ mA}$	3.0	—	6.0	V
Collector-emitter saturation voltage		$V_{CE (sat) (1)}$	$I_C = 10\text{ A}, V_{GE} = 15\text{ V}$	—	—	2.0	V
		$V_{CE (sat) (2)}$	$I_C = 80\text{ A}, V_{GE} = 15\text{ V}$	—	2.4	2.9	
Input capacitance		$C_{ies}$	$V_{CE} = 10\text{ V}, V_{GE} = 0, f = 1\text{ MHz}$	—	5500	—	pF
Switching time	Rise time	$t_r$	Resistive load $V_{CC} = 300\text{ V}, I_C = 80\text{ A}$ $V_{GG} = \pm 15\text{ V}, R_G = 33\Omega$  (Note 2)	—	0.3	—	$\mu\text{s}$
	Turn-on time	$t_{on}$		—	0.5	—	
	Fall time	$t_f$		—	0.25	0.40	
	Turn-off time	$t_{off}$		—	0.7	—	

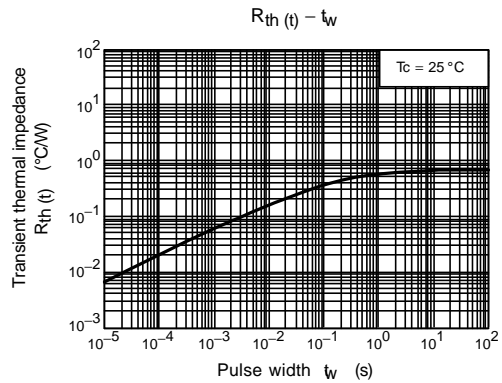
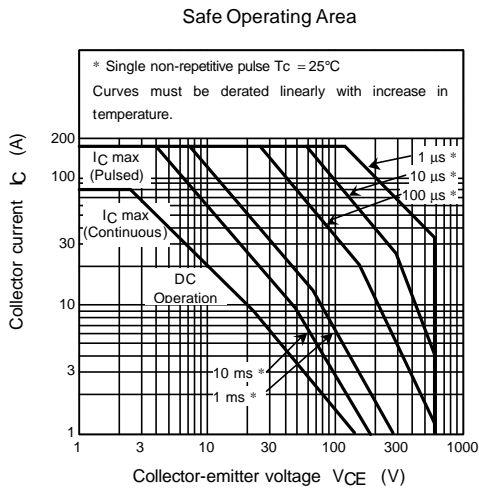
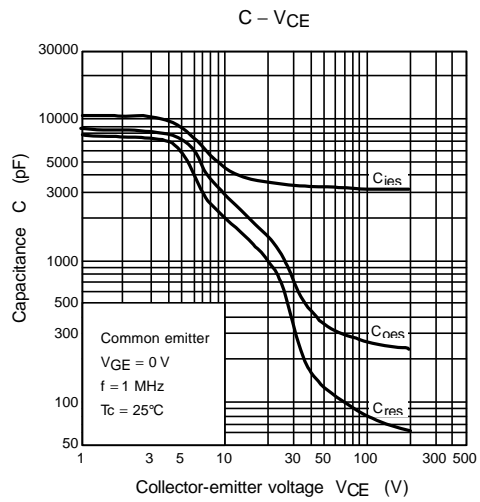
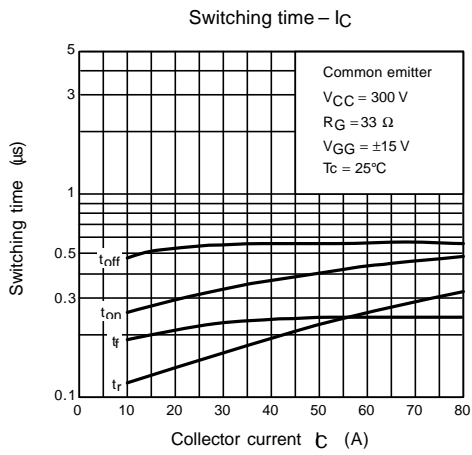
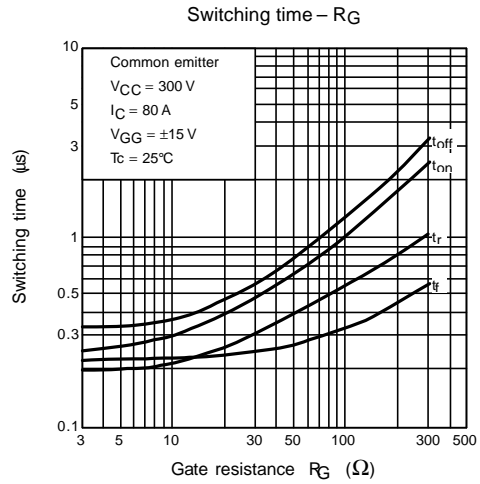
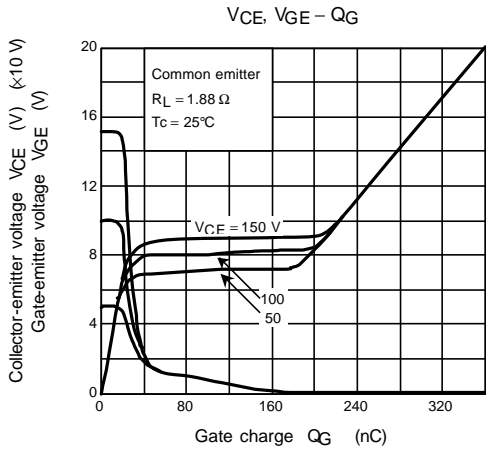
Note 2: Switching time measurement circuit and input/output waveforms.

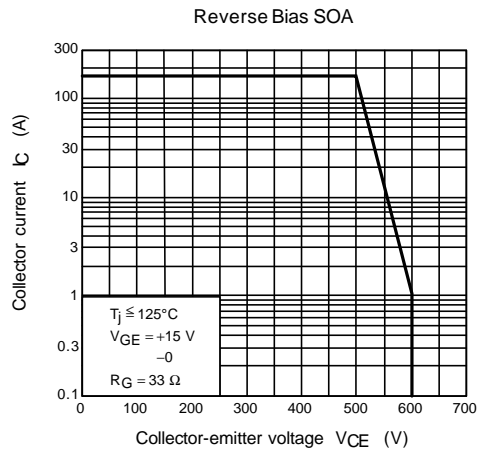


**Caution on handling**

This device is MOS gate type. Therefore, please care about ESD when use.







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